

**IISE Transactions** Call for Papers - Four Featured Special Issues!

(1) Digital Twin for the Advancement of Design and Manufacturing:

Deadline: 01 March 2026

Issue Editors: Chenang Liu, Michel-Alexandre Cardin, Jingshan Li, Debjit Roy, Ph.D., Chenhui Shao

More Details: [https://think.taylorandfrancis.com/special\\_issues/digital-twin-for-the-advancement-of-design-and-manufacturing/](https://think.taylorandfrancis.com/special_issues/digital-twin-for-the-advancement-of-design-and-manufacturing/)

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(2) Large-Scale Systemic Shocks in Manufacturing and Supply Chains:

Deadline: 31 December 2025

Issue Editors: Weiwei Chen, Alexandre Dolgui, Dmitry Ivanov, Nikolay Osadchiy

More Details: [https://think.taylorandfrancis.com/special\\_issues/large-scale-systemic-shocks-in-manufacturing-and-supply-chains/](https://think.taylorandfrancis.com/special_issues/large-scale-systemic-shocks-in-manufacturing-and-supply-chains/)

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(3) Advances in Reinforcement Learning and Large Language Models for Intelligent Systems:

Deadline: 30 November 2025

Issue Editors: Chen Zhang, Mostafa Reisi, Yisha Xiang, Bob Ziyue Li

More Details: [https://think.taylorandfrancis.com/special\\_issues/advances-in-reinforcement-learning-and-large-language-models-for-intelligent-systems/](https://think.taylorandfrancis.com/special_issues/advances-in-reinforcement-learning-and-large-language-models-for-intelligent-systems/)

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(4) Data Science for Computational Modeling, Design, Uncertainty Quantification, and Optimization:

Deadline: 31 March 2026

Issue Editors: Rui Tuo, Lulu Kang, Xiao Liu, Özge Sürer

More Details: [https://think.taylorandfrancis.com/special\\_issues/data-science-for-computational-modeling-dscm-design-uncertainty-quantification-and-optimization/](https://think.taylorandfrancis.com/special_issues/data-science-for-computational-modeling-dscm-design-uncertainty-quantification-and-optimization/)

We look forward to receiving your innovative work that aligns with IISE Transactions' vision and help drive the next wave of research in these critical areas.